

Data sheet acquired from Harris Semiconductor SCHS024C – Revised October 2003

# CMOS 8-Stage Static Shift Registers

High-Voltage Types (20-Volt Rating) CD4014B:

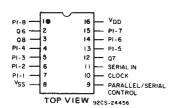
Synchronous Parallel or Serial Input/Serial Output

#### CD4021B:

Asynchronous Parallel Input or Synchronous Serial Input/Serial Output

■ CD4014B and CD4021B series types are 8-stage parallel- or serial-input/serial output registers having common CLOCK and PARALLEL/SERIAL CONTROL inputs, a single SERIAL data input, and individual parallel "JAM" inputs to each register stage. Each register stage is a D-type, master-slave flip-flop. In addition to an output from stage 8, "Q" outputs are also available from stages 6 and 7. Parallel as well as serial entry is made into the register synchronously with the positive clock line transition in the CD4014B. In the CD4021B serial entry is synchronous with the clock but parallel entry is asynchronous. In both types, entry is controlled by the PARALLEL/SERIAL CONTROL input. When the PARALLEL/SERIAL CON-TROL input is low, data is serially shifted into the 8-stage register synchronously with the positive transition of the clock line. When the PARALLEL/SERIAL CONTROL input is high, data is jammed into the 8-stage register via the parallel input lines and synchronous with the positive transition of the clock line. In the CD40218, the CLOCK input of the internal stage is "forced" when asynchronous parallel entry is made. Register expansion using multiple packages is per

The CD4014B and CD4021b series types are supplied in 16-lead hermetic dual-in-line ceramic packages (F3A suffix), 16-lead dual-in-line plastic packages (E suffix), 16-lead small-outline packages (M, M96, MT, and NSR suffixes), and 16-lead thin shrink small-outline packages (PW and PWR suffixes).



TERMINAL DIAGRAM CD4014B, CD4021B

# **CD4014B, CD4021B Types**

#### Features:

- Medium-speed operation . . . 12 MHz (typ.) clock rate at V<sub>DD</sub>-V<sub>SS</sub> = 10 V
- Fully static operation
- 8 master-slave flip-flops plus output buffering and control gating
- 100% tested for quiescent current at 20 V
- Maximum input current of 1 μA at 18 V over full package-temperature range; 100 nA at 18 V and 25°C
- Noise margin (full package-temperature range) = 1 V at V<sub>DD</sub> = 5 V

2 V at V<sub>DD</sub> = 10 V 2.5 V at V<sub>DD</sub> = 15 V

- Standardized, symmetrical output characteristics
- 5-V, 10-V, and 15-V parametric ratings
- Meets all requirements of JEDEC Tentative
   Standard No. 13B, "Standard Specifications for Description of 'B' Series CMOS Devices"

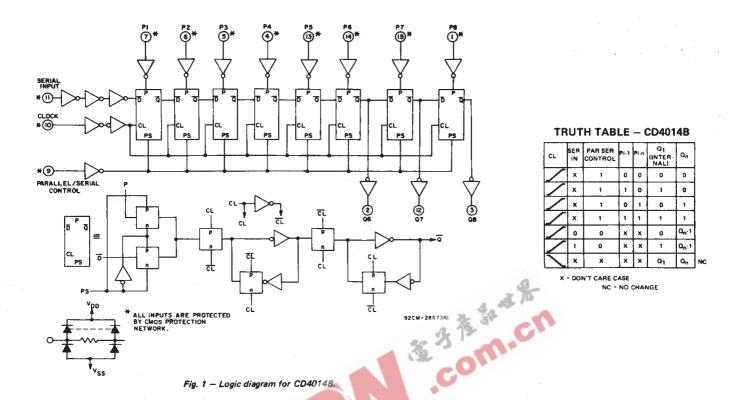
# 

#### Applications:

- Parallel input/serial output
  data queueing
- Parallel to serial data conversion
- General-purpose register

RECOMMENDED OPERATING CONDITIONS AT  $T_A = 25^{\circ}$ C, Unless Otherwise Specified For maximum reliability, nominal operating conditions should be selected so that operation is always within the following ranges.

is always within the following range	s.				
CHARACTERISTIC	V <sub>DD</sub>	LIN	UNITS		
	(V)	Min.	Max.	UNITS	
Supply Voltage Range (TA = Full Package-Temperature Range)	_	3	18	V	
Clock Pulse Width, t <sub>W</sub>	5 10 15	180 80 50	-	ns	
Clock Frequency, f <sub>CL</sub>	5 10 15	_ _ _	3 6 8.5	MHz	
Clock Rise and Fall Time, t <sub>r</sub> CL, t <sub>f</sub> CL	5 10 15	_ _ _	15 15 15	μs	
Set-up Time, t <sub>s</sub> : Serial Input (ref. to CL)	5 10 15	120 80 60	_ _ _	ns	
Parallel Inputs CD4014B (ref. to CL)	5 10 15	80 50 40	- - -	ns	
Parallel Inputs CD4021B (ref. to P/S)	5 10 15	50 30 20	_ _ _	ns	
Parallel/Serial Control CD4014B (ref. to CL)	5 10 15	180 80 60	- - -	ns	
Parallel/Serial Pulse Width, t <sub>W</sub> (CD4021B)	5 10 15	160 80 50	<u>-</u> `·	ns	
Parallel/Serial Removal Time, tREM (CD4021B)	5 10 15	280 140 100	- - -	ns	



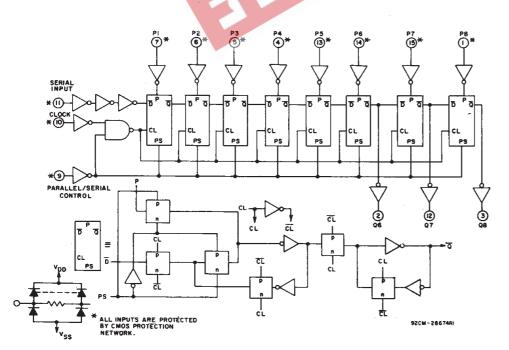


Fig. 2 - Logic diagram for CD40218.

### TRUTH TABLE - CD4021B

CL	Serial Input	Parallel/ Serial Control	PI-1	Pl∙n	Q <sub>1</sub> (Internal)	an	
х	×	1	0	0	0	0	1
х	х	1	0	1	0	1	1
х	×	1	1	0	1	0	
х	x	1	1	1	1	1	
/_	0	0	х	х	0	Q <sub>n</sub> ·1	
	1	0	х	х	1	Q <sub>n</sub> 1	
\_	х	0	х	х	Ω1	an	N

MAXIMUM RATINGS, Absolute-Maximum Values:	
DC SUPPLY-VOLTAGE RANGE, (VDD)	And the second
Voltages referenced to VSS Terminal)	
INPUT VOLTAGE RANGE, ALL INPUTS	0.5V to Vnn +0.5V
DC INPUT CURRENT, ANY ONE INPUT	
POWER DISSIPATION PER PACKAGE (Pn):	
For T <sub>A</sub> = -55°C to +100°C	500mW
For T <sub>A</sub> = +100°C to +125°C	
DEVICE DISSIPATION PER OUTPUT TRANSISTOR	
FOR TA = FULL PACKAGE-TEMPERATURE RANGE (All Package	Types)100mW
OPERATING-TEMPERATURE RANGE (TA)	55°C to +125°C
STORAGE TEMPERATURE RANGE (Talg)	65°C to +150°C
LEAD TEMPERATURE (DURING SOLDERING):	
At distance $1/16 \pm 1/32$ inch $(1.59 \pm 0.79$ mm) from case for 10s m	ax+265°C

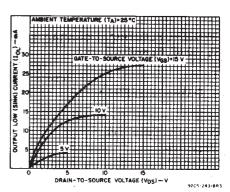
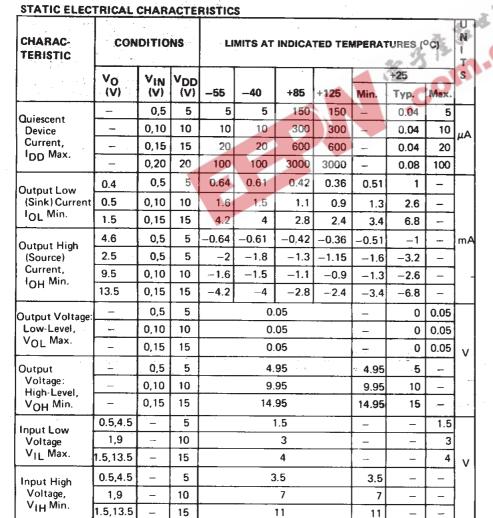


Fig. 3 — Typical output low (sink) current characteristics.



±0.1

±0.1

±1

±1

18

0,18

Input Current

I<sub>IN</sub> Max.

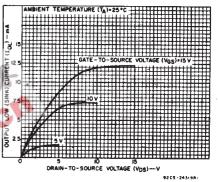


Fig. 4 – Minimum output low (sink) current characteristics.

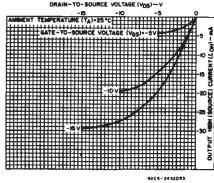


Fig. 5 — Typical output high (source) current characteristics.

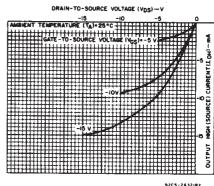


Fig. 6 — Minimum output high (source) current characteristics.

 $\pm 10^{-5}$ 

±0.1

DYNAMIC ELECTRICAL CHARACTERISTICS at T\_A=25°C, Input t\_r,t\_f=20 ns, C\_L=50 pF, R\_1=200 K $\Omega$ 

	TEST CONDITIONS		LIMITS				
CHARACTERISTIC		V <sub>DD</sub> (V)	Min.	Тур.	Max.	UNITS	
Propagation Delay Time,		- 5	_	160	320		
<sup>t</sup> PLH, <sup>t</sup> PHL		10	-	80	160	ns	
PLH, PHL		15	-	60	120		
Transition Time.		5	T -	100	200		
tTHL, tTLH		10	-	50	100	ns	
THEFTER		15		40	80		
Maximum Clock Input	1	5	3	6	_		
Frequency, f <sub>CL</sub>		10	6	12	<b>i</b> –	MHz	
	<u> </u>	15	8.5	17	_		
Minimum Clock Pulse		. 5	_	90	180		
Width, tw		10	-	40	80	ns	
		15		25	50		
Clock Rise and Fall Time,		5	_	-	15		
t <sub>r</sub> CL, t <sub>f</sub> CL*		10	-	_	15	μs	
		15		_	15	2 76	
Minimum Set-up Time, t <sub>s</sub> :		5		60	120 🦔	- 75 1	
Serial Input		10	-	40	80	ns	
(ref. to CL)	L	15	-	30	60	- O	
Parallel Inputs		5		40	80		
CD4014B		10	-	25	50	ns	
(ref. to CL)		15	-	20	40		
Parallel Inputs		5	-	25	50		
CD4021B		10	-	15	30	ns	
(ref. to P/S)	1	15	_	10	20		
Parallel/Serial Control		5	-	90	180		
CD4014B		10	-	40	80	ns	
(ref. to CL)		15	_	30	60		
Minimum Hold Time, tH:		5	_	_	0		
Serial In, Parallel In,		10	_	_	0	ns	
Parallel/Serial Control		15	_		0		
Minimum P/S Pulse Width,		5	-	80	160		
tWH		10		40	80	ns	
(CD4021B)	İ	15	-	25	50		
Minimum P/S Removal Time,		5		140	280		
<sup>t</sup> REM		10	_	70	140	ns	
CD4021B (ref. to CL)		15	- 1	50	100		
		Input					

<sup>\*</sup> If more than one unit is cascaded t<sub>r</sub>CL should be made less than or equal to the sum of the transition time and the fixed propagation delay of the output of the driving stage for the estimated capacitive load.

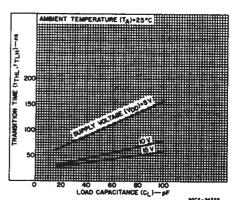


Fig. 7 — Typical transition time as a function of load capacitance.

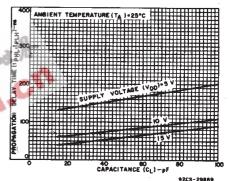


Fig. 8 — Typical propagation delay time as a function of load capacitance.

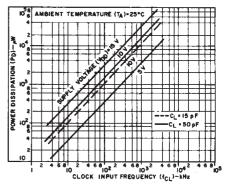


Fig. 9 — Typical dynamic power dissipation as a function of clock input frequency.

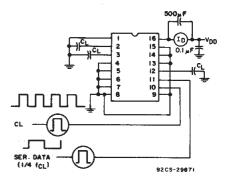


Fig. 10 - Dynamic power dissipation test circuit.

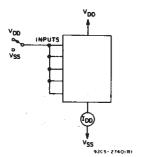


Fig. 11 — Quiescent device current test circuit.

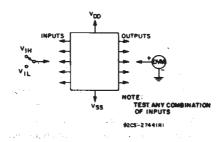


Fig. 12 - Input voltage test circuit.

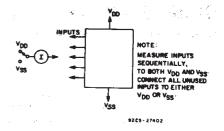
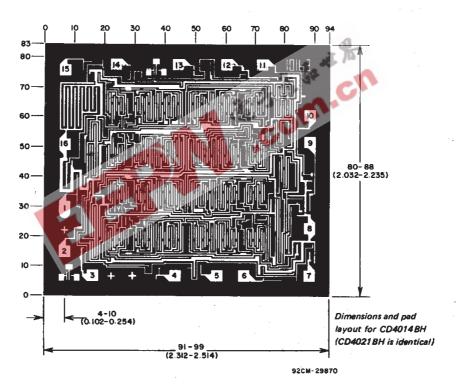


Fig. 13 - Input current test circuit.



Dimensions in perentheses are in millimeters and are derived from the basic inch dimensions as indicated. Grid graduations are in mils  $(10^{-3} \text{ inch})$ .



### PACKAGE OPTION ADDENDUM

28-Feb-2005

### **PACKAGING INFORMATION**

Orderable Device	Status <sup>(1)</sup>	Package Type	Package Drawing	Pins	Package Qty	Eco Plan <sup>(2)</sup>	Lead/Ball Finish	MSL Peak Temp <sup>(3)</sup>
CD4014BE	ACTIVE	PDIP	N	16	25	Pb-Free (RoHS)	CU NIPDAU	Level-NC-NC-NC
CD4014BF3A	ACTIVE	CDIP	J	16	1	None	Call TI	Level-NC-NC-NC
CD4014BM	ACTIVE	SOIC	D	16	40	Pb-Free (RoHS)	CU NIPDAU	Level-2-260C-1 YEAR/ Level-1-235C-UNLIM
CD4014BM96	ACTIVE	SOIC	D	16	2500	Pb-Free (RoHS)	CU NIPDAU	Level-2-260C-1 YEAR/ Level-1-235C-UNLIM
CD4014BMT	ACTIVE	SOIC	D	16	250	Pb-Free (RoHS)	CU NIPDAU	Level-2-260C-1 YEAR/ Level-1-235C-UNLIM
CD4014BNSR	ACTIVE	SO	NS	16	2000	Pb-Free (RoHS)	CU NIPDAU	Level-2-260C-1 YEAR/ Level-1-235C-UNLIM
CD4014BPW	ACTIVE	TSSOP	PW	16	90	Pb-Free (RoHS)	CU NIPDAU	Level-1-250C-UNLIM
CD4014BPWR	ACTIVE	TSSOP	PW	16	2000	Pb-Free (RoHS)	CU NIPDAU	Level-1-250C-UNLIM
CD4021BE	ACTIVE	PDIP	N	16	25	Pb-Free (RoHS)	CU NIPDAU	Level-NC-NC-NC
CD4021BF	ACTIVE	CDIP	J	16	71	None	Call TI	Level-NC-NC-NC
CD4021BF3A	ACTIVE	CDIP	J	16	1	None	Call TI	Level-NC-NC-NC
CD4021BM	ACTIVE	SOIC	D	16	40	Pb-Free (RoHS)	CU NIPDAU	Level-2-260C-1 YEAR/ Level-1-235C-UNLIM
CD4021BM96	ACTIVE	SOIC	D	16	2500	Pb-Free (RoHS)	CU NIPDAU	Level-2-260C-1 YEAR/ Level-1-235C-UNLIM
CD4021BMT	ACTIVE	SOIC	D	16	250	Pb-Free (RoHS)	CU NIPDAU	Level-2-260C-1 YEAR/ Level-1-235C-UNLIM
CD4021BNSR	ACTIVE	so	NS	16	2000	Pb-Free (RoHS)	CU NIPDAU	Level-2-260C-1 YEAR/ Level-1-235C-UNLIM
CD4021BPW	ACTIVE	TSSOP	PW	16	90	Pb-Free (RoHS)	CU NIPDAU	Level-1-250C-UNLIM
CD4021BPWR	ACTIVE	TSSOP	PW	16	2000	Pb-Free (RoHS)	CU NIPDAU	Level-1-250C-UNLIM
JM38510/05754BEA	ACTIVE	CDIP	J	16	1	None	Call TI	Level-NC-NC-NC

<sup>&</sup>lt;sup>(1)</sup> The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE**: TI has discontinued the production of the device.

None: Not yet available Lead (Pb-Free).

Pb-Free (RoHS): Tl's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements. for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Green (RoHS & no Sb/Br): TI defines "Green" to mean "Pb-Free" and in addition, uses package materials that do not contain halogens, including bromine (Br) or antimony (Sb) above 0.1% of total product weight.

<sup>(2)</sup> Eco Plan - May not be currently available - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

<sup>(3)</sup> MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDECindustry standard classifications, and peak solder temperature.



### PACKAGE OPTION ADDENDUM

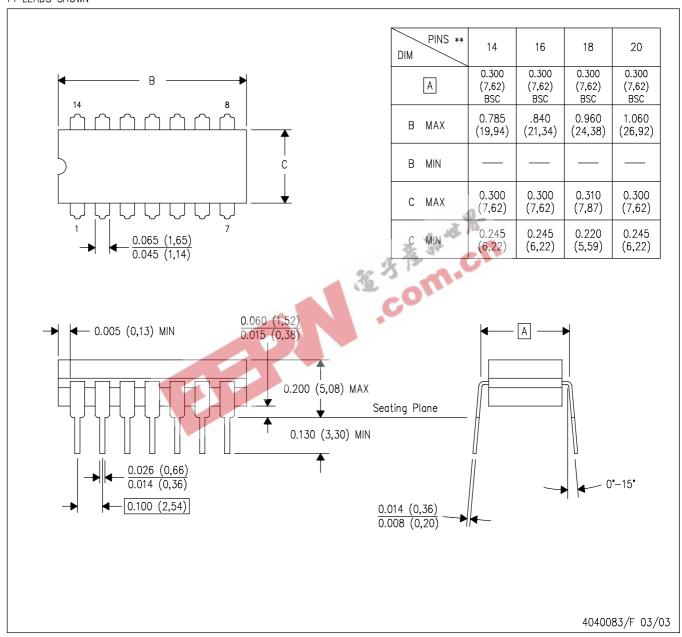
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14 LEADS SHOWN

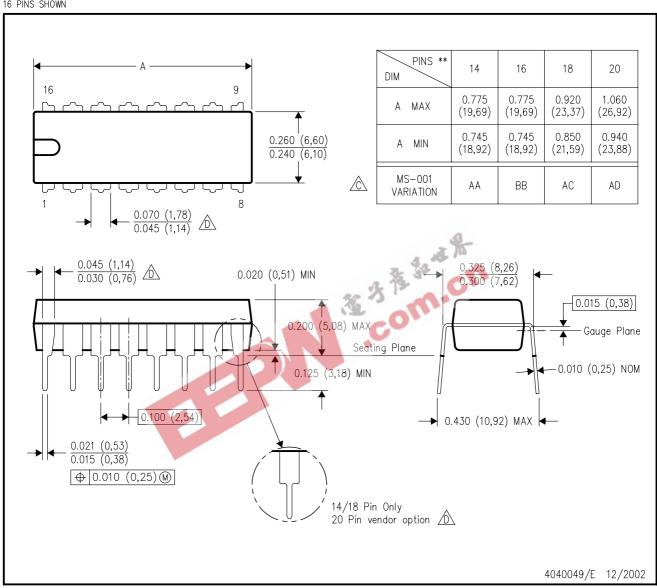


- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- C. This package is hermetically sealed with a ceramic lid using glass frit.
- D. Index point is provided on cap for terminal identification only on press ceramic glass frit seal only.
- $E. \quad \text{Falls within MIL STD 1835 GDIP1-T14, GDIP1-T16, GDIP1-T18 and GDIP1-T20.} \\$

# N (R-PDIP-T\*\*)

# PLASTIC DUAL-IN-LINE PACKAGE

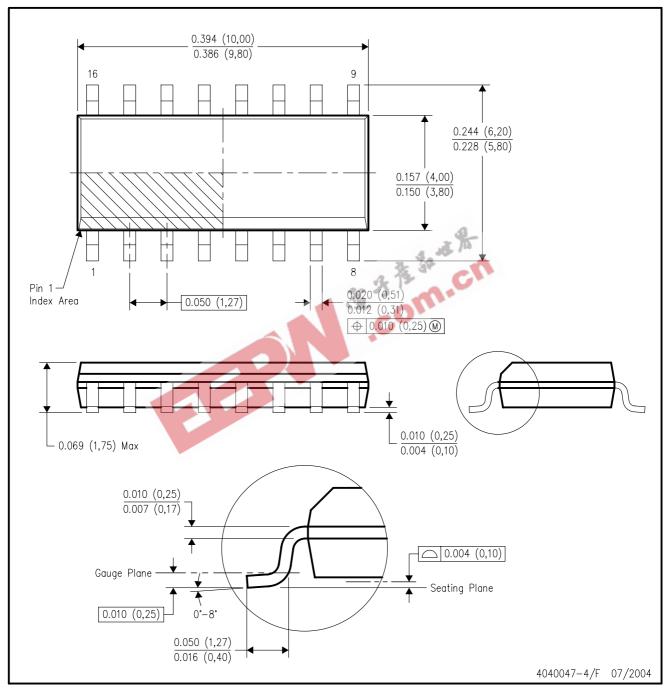
16 PINS SHOWN



- All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- Falls within JEDEC MS-001, except 18 and 20 pin minimum body length (Dim A).
- The 20 pin end lead shoulder width is a vendor option, either half or full width.

# D (R-PDSO-G16)

# PLASTIC SMALL-OUTLINE PACKAGE



- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15).
- D. Falls within JEDEC MS-012 variation AC.

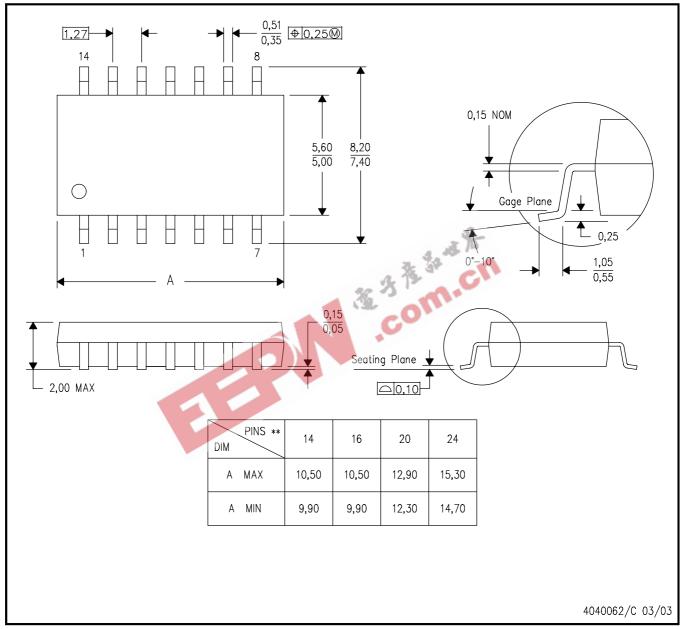


### **MECHANICAL DATA**

# NS (R-PDSO-G\*\*)

# 14-PINS SHOWN

### PLASTIC SMALL-OUTLINE PACKAGE



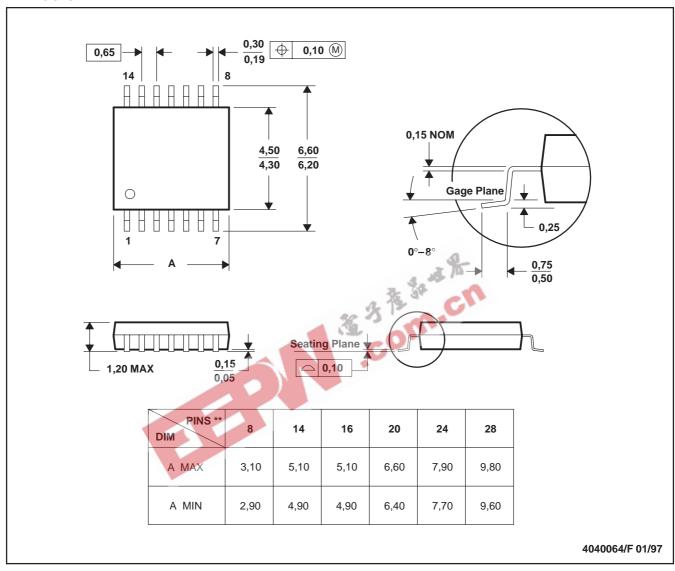
- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion, not to exceed 0,15.



### PW (R-PDSO-G\*\*)

### PLASTIC SMALL-OUTLINE PACKAGE

### 14 PINS SHOWN



NOTES: A. All linear dimensions are in millimeters.

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold flash or protrusion not to exceed 0,15.

D. Falls within JEDEC MO-153

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